

Data Sheet

July 1999

File Number

er 2410.2

4.6A, 200V, 0.800 Ohm, N-Channel Power MOSFETs

These are N-Channel enhancement mode silicon gate power field effect transistors. They are advanced power MOSFETs designed, tested, and guaranteed to withstand a specified level of energy in the breakdown avalanche mode of operation. All of these power MOSFETs are designed for applications such as switching regulators, switching convertors, motor drivers, relay drivers, and drivers for high power bipolar switching transistors requiring high speed and low gate drive power. These types can be operated directly from integrated circuits.

Formerly developmental type TA9600.

Ordering Information

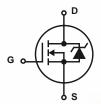
PART NUMBER	PACKAGE	BRAND
IRFR220	TO-252AA	IFR220
IRFU220	TO-251AA	IFU220

NOTE: When ordering, use the entire part number.

Features

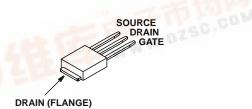
- 4.6A, 200V
- $r_{DS(ON)} = 0.800\Omega$
- Single Pulse Avalanche Energy Rated
- SOA is Power Dissipation Limited
- Nanosecond Switching Speeds
- · Linear Transfer Characteristics
- High Input Impedance
- Related Literature
 - TB334 "Guidelines for Soldering Surface Mount Components to PC Boards"

Symbol

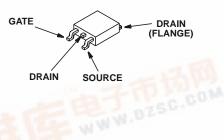


Packaging

JEDEC TO-251AA









IRFR220, IRFU220

Absolute Maximum Ratings $T_C = 25^{\circ}C$, Unless Otherwise Specfied

	IRFR220, IRFU220	UNITS
Drain to Source Voltage (Note 1)	200	V
Drain to Gate Voltage ($R_{GS} = 20k\Omega$) (Note 1)	200	V
Continuous Drain Current	4.6	Α
$T_C = 100^{\circ}C$	2.9	Α
Pulsed Drain Current (Note 3)	18	Α
Gate to Source Voltage	±20	V
Maximum Power Dissipation	50	W
Linear Derating Factor	0.4	W/oC
Single Pulse Avalanche Energy Rating (Note 4)	85	mJ
Operating and Storage Temperature	-55 to 150	οС
Maximum Temperature for Soldering		
Leads at 0.063in (1.6mm) from Case for 10sT _L	300	οС
Package Body for 10s, See Techbrief 334	260	oC

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE:

1. $T_J = 25^{\circ}C$ to $125^{\circ}C$.

Electrical Specifications $T_C = 25^{\circ}C$, Unless Otherwise Specified

PARAMETER	SYMBOL	TEST COND	ITIONS	MIN	TYP	MAX	UNITS
Drain to Source Breakdown Voltage	BV _{DSS}	$I_D = 250\mu A, V_{GS} = 0V, (Figure 10)$		200	-	-	V
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} = V _{DS} , I _D = 250μA		2.0	-	4.0	V
Zero Gate Voltage Drain Current IDSS		V _{DS} = Rated BV _{DSS} , V _{GS} = 0V		-	-	25	μА
		V _{DS} = 0.8 x Rated BV _{DSS} ,	$V_{GS} = 0V, T_J = 125^{\circ}C$	-	-	250	μА
On-State Drain Current (Note 2)	I _{D(ON)}	$V_{DS} > I_{D(ON)} \times r_{DS(ON)MAX}, V_{GS} = 10V,$ (Figure 7) $V_{GS} = \pm 20V$ $I_{D} = 2.4A, V_{GS} = 10V,$ (Figures 8, 9) $V_{DS} \ge 50V, I_{D} = 2.4A,$ (Figure 12)		4.6	-	-	А
Gate to Source Leakage Current	I _{GSS}			-	-	±100	nA
Drain to Source On Resistance (Note 2)	r _{DS(ON)}			-	0.47	0.800	Ω
Forward Transconductance (Note 2)	9 _{fs}			1.7	2.6	-	S
Turn-On Delay Time	t _{d(ON)}	$\begin{array}{l} V_{DD} = 100 \text{V, I}_D \approx 4.6 \text{A, R}_{GS} = 18 \Omega, \text{R}_L = 18 \Omega, \\ V_{GS} = 10 \text{V} \\ \text{MOSFET Switching Times are Essentially Independent of Operating Temperature} \end{array}$		-	8.8	13	ns
Rise Time	t _r			-	27	41	ns
Turn-Off Delay Time	t _{d(OFF)}			-	21	32	ns
Fall Time	t _f			-	14	21	ns
Total Gate Charge (Gate to Source + Gate to Drain)	Q _{g(TOT)}	$V_{GS} = 10V, I_D = 4.6A, V_{DS} = 0.8 \text{ x Rated BV}_{DSS}, \\ I_{g(REF)} = 1.5\text{mA}, (Figure 14) \\ \text{Gate Charge is Essentially Independent of Operating Temperature} \\ V_{DS} = 25V, V_{GS} = 0V, f = 1\text{MHz}, (Figure 11)$		-	12	18	nC
Gate to Source Charge	Q _{gs}			-	2.3	3.4	nC
Gate to Drain "Miller" Charge	Q _{gd}			-	4.5	6.8	nC
Input Capacitance	C _{ISS}			-	330	-	pF
Output Capacitance	C _{OSS}			-	120	-	pF
Reverse Transfer Capacitance	C _{RSS}			-	41	-	pF
Internal Drain Inductance	L _D	Lead, 6.0mm (0.25in)	Modified MOSFET Symbol Showing the Internal Device Inductances	-	4.5	-	nH
Internal Source Inductance	L _S	Measured From the Source Lead, 6.0mm (0.25in) From Package to Source Bonding Pad	G O ELS	-	7.5	-	nH
Thermal Resistance, Junction to Case	$R_{\theta JC}$			-	-	2.5	°C/W
Thermal Resistance, Junction to Ambient	$R_{\theta JA}$	Typical Solder Mount		-	-	110	°C/W

IRFR220, IRFU220

Source to Drain Diode Specifications

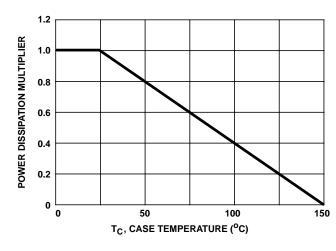
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Continuous Source to Drain Current	I _{SD}	Modified MOSFET Sym-	-	-	4.6	Α
Pulse Source to Drain Current (Note 3)	^I SDM	bol Showing the Integral Reverse P-N Junction Rectifier)	-	18	A
Source to Drain Diode Voltage (Note 2)	V_{SD}	$T_J = 25^{\circ}C$, $I_{SD} = 4.6A$, $V_{GS} = 0V$, (Figure 13)	-	-	1.8	V
Reverse Recovery Time	t _{rr}	$T_J = 25^{\circ}C$, $I_{SD} = 4.6A$, $dI_{SD}/dt = 100A/\mu s$	69	170	400	ns
Reverse Recovery Charge	Q _{RR}	$T_J = 25^{\circ}C$, $I_{SD} = 4.6A$, $dI_{SD}/dt = 100A/\mu s$	0.30	0.72	1.8	μС

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NOTES:

- 2. Pulse test: pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.
- 3. Repetitive rating: pulse width limited by maximum junction temperature. See Transient Thermal Impedance curve (Figure 3).
- 4. V_{DD} = 10V, starting T_J = 25 0 C, L = 6.18mH, R_G = 50 Ω , peak I_{AS} = 4.6A.

Typical Performance Curves Unless Otherwise Specified



ID, DRAIN CURRENT (A) 25 50 100 125 150 T_C, CASE TEMPERATURE (°C)

FIGURE 1. NORMALIZED POWER DISSIPATION vs CASE **TEMPERATURE**

FIGURE 2. MAXIMUM CONTINUOUS DRAIN CURRENT vs **CASE TEMPERATURE**

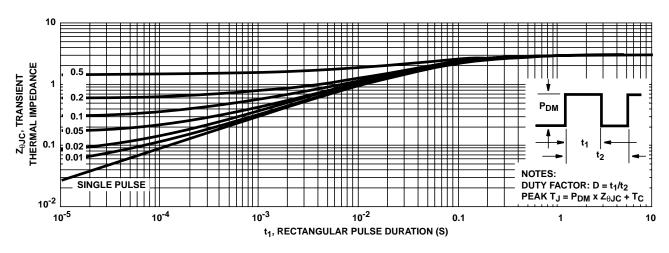


FIGURE 3. MAXIMUM TRANSIENT THERMAL IMPEDANCE

Typical Performance Curves Unless Otherwise Specified (Continued)

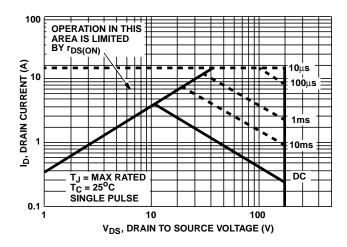


FIGURE 4. FORWARD BIAS SAFE OPERATING AREA

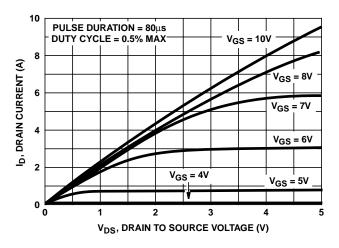


FIGURE 6. SATURATION CHARACTERISTICS

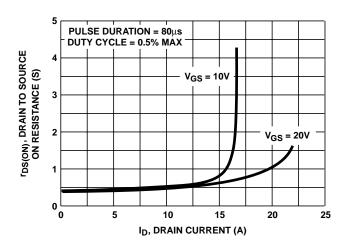


FIGURE 8. DRAIN TO SOURCE ON RESISTANCE vs GATE VOLTAGE AND DRAIN CURRENT

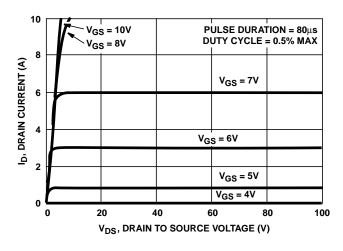


FIGURE 5. OUTPUT CHARACTERISTICS

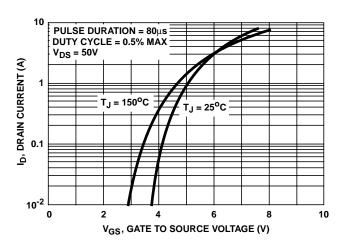


FIGURE 7. TRANSFER CHARACTERISTICS

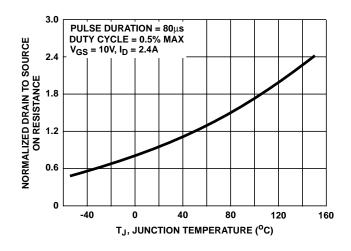


FIGURE 9. NORMALIZED DRAIN TO SOURCE ON RESISTANCE vs JUNCTION TEMPERATURE

Typical Performance Curves Unless Otherwise Specified (Continued)

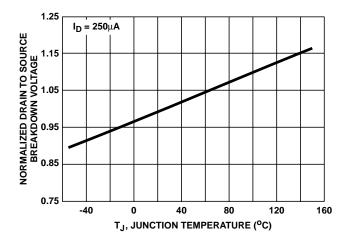


FIGURE 10. NORMALIZED DRAIN TO SOURCE BREAKDOWN VOLTAGE vs JUNCTION TEMPERATURE

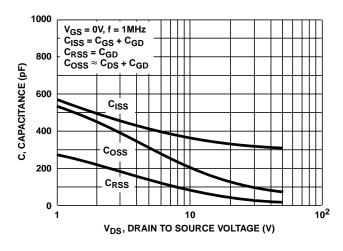


FIGURE 11. CAPACITANCE vs DRAIN TO SOURCE VOLTAGE

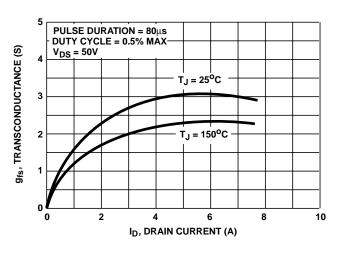


FIGURE 12. TRANSCONDUCTANCE vs DRAIN CURRENT

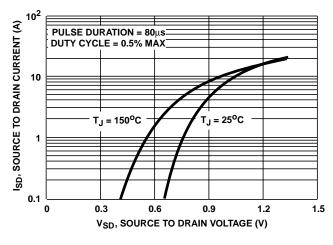


FIGURE 13. SOURCE TO DRAIN DIODE VOLTAGE

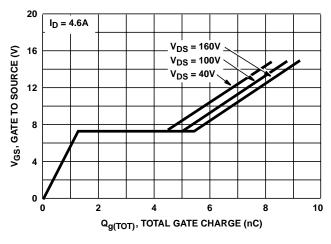


FIGURE 14. GATE TO SOURCE VOLTAGE vs GATE CHARGE

Test Circuits and Waveforms

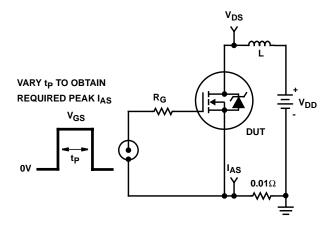


FIGURE 15. UNCLAMPED ENERGY TEST CIRCUIT

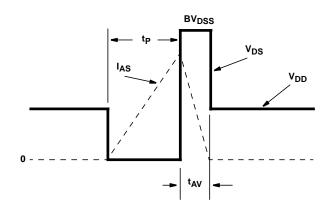


FIGURE 16. UNCLAMPED ENERGY WAVEFORMS

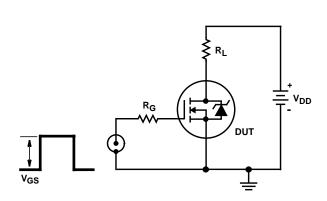


FIGURE 17. SWITCHING TIME TEST CIRCUIT

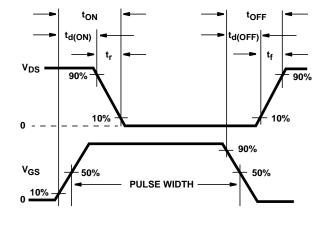


FIGURE 18. RESISTIVE SWITCHING WAVEFORMS

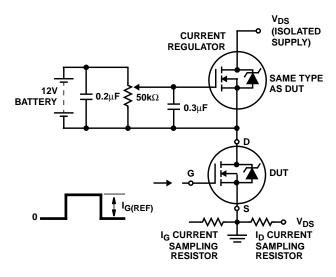


FIGURE 19. GATE CHARGE TEST CIRCUIT

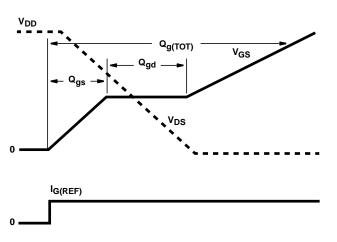


FIGURE 20. GATE CHARGE WAVEFORMS

IRFR220, IRFU220

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